Se	arch	Note	s

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,743	HUBER ET AL.
Examiner	Art Unit
Chapman E. Jeanette	3635

Chapman E. Jeanette

	SEARCHED		
Class	Subclass	Date	Examiner
52	415-441	11/9/2006	JC
	294-299	-	
	<del></del>		

· INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEARC	HSTRATEGY	()
	DATE	EXMR
,		
	· · ·	
		-
		-
<u> </u>		